


<b>Search Notes</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/611,295	SHEI, STEVEN M.	
	Examiner	Art Unit	
	Joseph M. Pelham	3742	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
219/394,411		
220/367.1		
See history	3/6/00	JP